Dual N-Channel MOSFET

General Description

The WSD2010DN25 is the highest performance trench N-Channel MOSFETs with extreme high cell density, which provide excellent RDSON and gate charge for most of the small power switching and load switch applications.

The WSD2010DN25 meet the RoHS and Green Product requirement with full function reliability approved.

Features

- Advanced high cell density Trench technology
- Super Low Gate Charge
- Excellent Cdv/dt effect decline
- Green Device Available

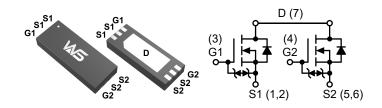
Product Summery

BV _{DSS}	R _{DSON}	l _D
20V	6.0mΩ	11A

Applications

- Power management in portable and battery operated products
- DC-DC Power System
- ESD:2KV

DFN2X5-6S Pin Configuration



Absolute Maximum Ratings

Symbol	Parameter	Rating	Units
V_{DS}	Drain-Source Voltage	20	V
V_{GS}	Gate-Source Voltage	±12	V
I _D @T _A =25℃	Continuous Drain Current, V _{GS} @ 4.5V ¹	11	Α
I _D @T _A =70°C	Continuous Drain Current, V _{GS} @ 4.5V ¹	7.5	Α
I _{DM}	Pulsed Drain Current ²	38	Α
P _D @T _A =25℃	P _D @T _A =25℃ Total Power Dissipation ³		W
P _D @T _A =70°C	P _D @T _A =70°C Total Power Dissipation ³		W
T _{STG}	T _{STG} Storage Temperature Range		$^{\circ}$ C
T _J Operating Junction Temperature Range		-55 to 150	$^{\circ}$ C

Thermal Data

Symbol	Parameter	Тур.	Max.	Unit
$R_{ heta JA}$	Thermal Resistance Junction-ambient ¹ (Steady State)		127	°C/W
$R_{ heta JA}$	Thermal Resistance Junction-ambient 1 (t<10S)		80	°C/W

Dual N-Channel MOSFET

Electrical Characteristics ÁQVJMÁG »Ô,ÁW} |^••ÁUc@t¸ ã^Áp[c^åD

Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit	
BV _{DSS}	Drain-Source Breakdown Voltage	V _{GS} =0V , I _D =250uA	20			V	
$\triangle BV_{DSS}/\triangle T_{J}$	BVDSS Temperature Coefficient	Reference to 25℃ , I _D =1mA		0.022		V/℃	
D	Static Drain-Source On-Resistance ²	V _{GS} =4.5V , I _D =5.5A		6.0	7.5	mΩ	
R _{DS(ON)}	Static Drain-Source On-Resistance	V _{GS} =2.5V , I _D =5.5A		7.3	9.9		
V _{GS(th)}	Gate Threshold Voltage	V =V 1 =250··A	0.5	0.7	1.0	V	
$\triangle V_{GS(th)}$	V _{GS(th)} Temperature Coefficient	$V_{GS}=V_{DS}$, $I_D=250uA$		-2.32		mV/℃	
,	Drain Source Leakage Current	V_{DS} =16V , V_{GS} =0V , T_J =25 $^{\circ}$ C			1		
I _{DSS}	Drain-Source Leakage Current	V _{DS} =16V , V _{GS} =0V , T _J =55℃			5	μA	
I _{GSS}	Gate-Source Leakage Current	V_{GS} = \pm 12 V , V_{DS} =0 V			±10	μA	
gfs	Forward Transconductance	orward Transconductance V _{DS} =5V , I _D =10A		30		S	
Rg	Gate Resistance	V _{DS} =0V , V _{GS} =0V , f=1MHz		11		Ω	
Qg	Total Gate Charge (4.5V)	te Charge (4.5V)		23.2	26		
Q _{gs}	Gate-Source Charge	V _{DS} =10V , V _{GS} =4.5V , I _D =5.5A		1.9	5.5	nC	
Q _{gd}	Gate-Drain Charge			4.8	9.2		
T _{d(on)}	Turn-On Delay Time			8	15		
Tr	Rise Time	V_{DD} =10V , V_{GS} =10V , R_{G} =1 Ω ,		20	36		
T _{d(off)}	Turn-Off Delay Time	I _D =1A ,RL=10Ω		935	1583	ns	
T _f	Fall Time			410	738		
C _{iss}	Input Capacitance			1470	1920		
C _{oss}	Output Capacitance	V _{DS} =10V , V _{GS} =0V , f=1MHz		258		pF	
C _{rss}	Reverse Transfer Capacitance			202			

Diode Characteristics

Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit
Is	Continuous Source Current ^{1,4}	\/ -\/ -0\/ Force Current			2	Α
I _{SM}	Pulsed Source Current ^{2,4}	V _G =V _D =0V , Force Current			38	Α
V_{SD}	Diode Forward Voltage ² V _{GS} =0V , I _S =1A , T _J =25℃				1.2	V
t _{rr}	Reverse Recovery Time			445		nS
Q _{rr}	Reverse Recovery Charge	IF=5.5A,dI/dt=100A/µs , Tյ=25℃		2175		nC

Note:

- 1. The data tested by surface mounted on a 1 inch² FR-4 board with 2OZ copper, t<10sec.
- 2.The data tested by pulsed , pulse width \leqq 300us , duty cycle \leqq 2%
- $\textbf{4.The data is theoretically the same as } \textbf{I}_{D} \text{ and } \textbf{I}_{DM} \text{ , in real applications , should be limited by total power dissipation.}$



Typical Characteristics

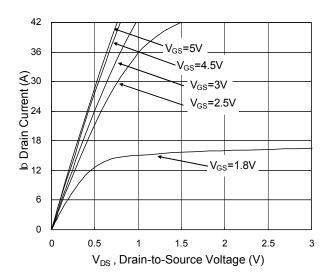


Fig.1 Typical Output Characteristics

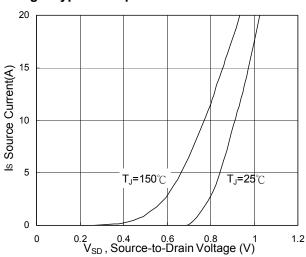


Fig.3 Forward Characteristics Of Reverse

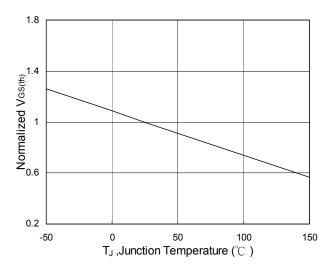


Fig.5 $V_{GS(th)}$ vs. T_J

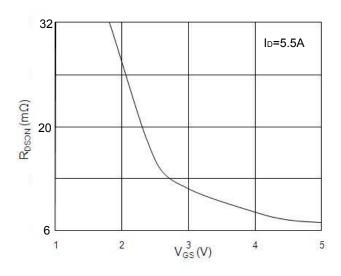


Fig.2 On-Resistance vs. Gate-Source

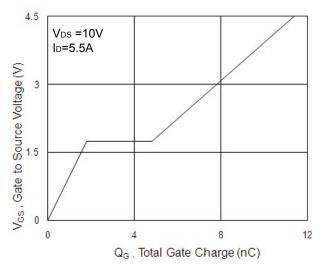


Fig.4 Gate-Charge Characteristics

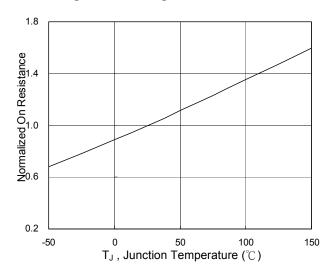
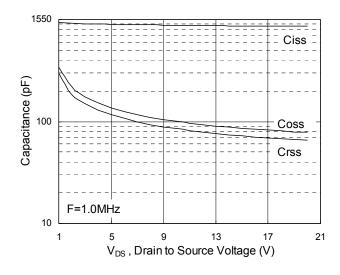


Fig.6 Normalized R_{DSON} vs. T_J



Typical Characteristics (Cont.)



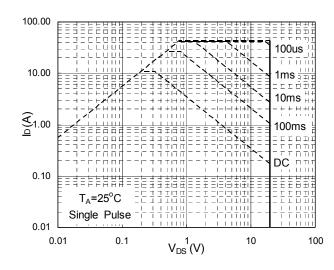


Fig.7 Capacitance

Fig.8 Safe Operating Area

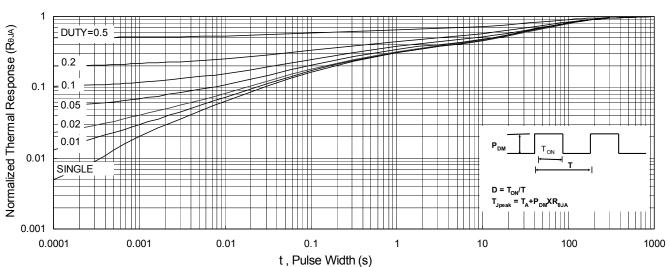
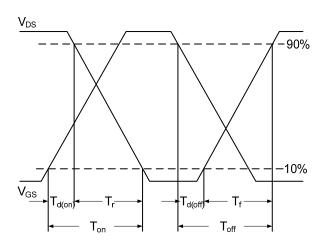
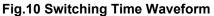


Fig.9 Normalized Maximum Transient Thermal Impedance





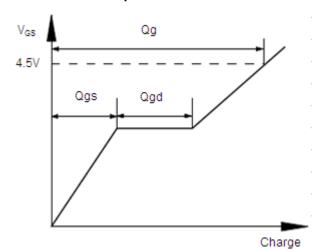
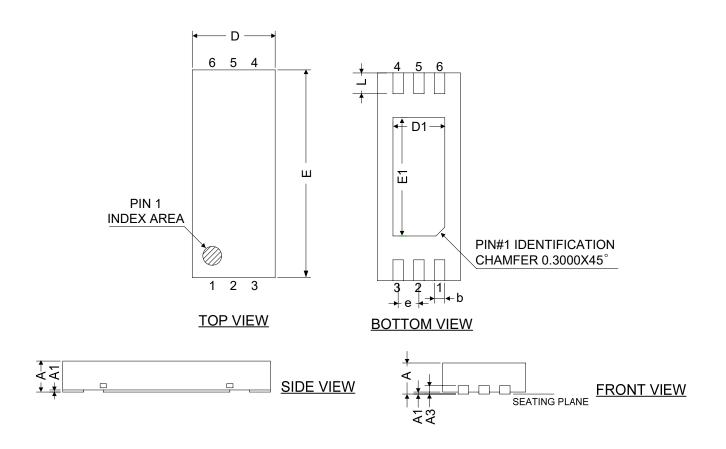


Fig.11 Gate Charge Waveform

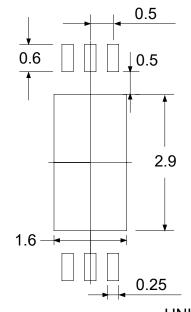


Packaging information



S	DFN2X5-6S					
SYMBOL	MILLIM	ETERS	INC	HES		
P L	MIN.	MAX.	MIN.	MAX.		
Α	0.70	1.00	0.028	0.039		
A1	0.00	0.05	0.000	0.002		
А3	0.10	0.203	0.004	0.008		
b	0.20	0.30	0.008	0.012		
D	1.90	2.10	0.075	0.083		
D1	1.20	1.55	0.047	0.061		
Е	4.80	5.20	0.189	0.205		
E1	2.60	2.95	0.102	0.116		
е	0.50 BSC		0.02	0 BSC		
L	0.40	0.60	0.016	0.024		

RECOMMENDED LAND PATTERN



UNIT: mm



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